

TRENCHSTOP<sup>™</sup> Series

## Low Loss IGBT : IGBT in TRENCHSTOP™ and Fieldstop technology





#### Features:

- Very low V<sub>CE(sat)</sub> 1.5V (typ.)
- Maximum Junction Temperature 175°C
- Short circuit withstand time 5µs
- Designed for frequency inverters for washing machines, fans, pumps and vacuum cleaners
- TRENCHSTOP<sup>™</sup> technology for 600V applications offers :
  - very tight parameter distribution
    - high ruggedness, temperature stable behavior
    - very high switching speed
- Positive temperature coefficient in V<sub>CE(sat)</sub>
- Low EMI
- Low Gate Charge
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1</sup> for target applications
- Complete product spectrum and PSpice Models : <u>http://www.infineon.com/igbt/</u>

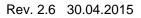
Туре	V <sub>CE</sub>	<i>I</i> c	V <sub>CE(sat), Tj=25°C</sub>	<b>T</b> <sub>j,max</sub>	Marking Code	Package
IGB15N60T	600V	15A	1.5V	175°C	G15T60	PG-TO263-3

#### **Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, $T_j \ge 25^{\circ}C$	V <sub>CE</sub>	600	V
DC collector current, limited by $T_{jmax}$			
$T_{\rm C} = 25^{\circ}$ C, value limited by bondwire	I <sub>C</sub>	26	
$T_{\rm C} = 100^{\circ}{\rm C}$		23	A
Pulsed collector current, $t_p$ limited by $T_{jmax}$	<i>I</i> <sub>Cpuls</sub>	45	
Turn off safe operating area, $V_{CE} = 600V$ , $T_j = 175^{\circ}C$ , $t_p = 1\mu s$	-	45	
Gate-emitter voltage	V <sub>GE</sub>	±20	V
Short circuit withstand time <sup>2)</sup>	4	F	
$V_{\rm GE}$ = 15V, $V_{\rm CC} \le 400$ V, $T_{\rm j} \le 150^{\circ}$ C	t <sub>sc</sub>	5	μS
Power dissipation $T_{\rm C} = 25^{\circ}{\rm C}$	P <sub>tot</sub>	130	W
Operating junction temperature	Tj	-40+175	
Storage temperature	T <sub>stg</sub>	-55+150	°C
Soldering temperature (reflow soldering, MSL1)		260	

<sup>1</sup> J-STD-020 and JESD-022

<sup>2)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.





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#### **Thermal Resistance**

Parameter	Symbol	Conditions	Max. Value	Unit				
Characteristic								
IGBT thermal resistance,	R <sub>thJC</sub>		1.15	K/W				
junction – case								
Thermal resistance,	R <sub>thJA</sub>	6cm <sup>2</sup> Cu	40					
junction - ambient								

### **Electrical Characteristic,** at $T_j$ = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit	
Falameter	Symbol	Conditions	min.	Тур.	max.		
Static Characteristic							
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}=0V, I_{C}=0.2mA$	600	-	-	V	
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	$V_{\rm GE} = 15 \rm V, \ I_{\rm C} = 15 \rm A$					
		T <sub>j</sub> =25°C	-	1.5	2.05		
		<i>T</i> <sub>j</sub> =175°C	-	1.9	-		
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_{\rm C} = 210 \mu {\rm A}, V_{\rm CE} = V_{\rm GE}$	4.1	4.9	5.7		
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V				μA	
		T <sub>j</sub> =25°C	-	-	40		
		<i>T</i> <sub>j</sub> =175°C	-	-	1000		
Gate-emitter leakage current	I <sub>GES</sub>	$V_{\rm CE} = 0  \text{V},  V_{\rm GE} = 20  \text{V}$	-	-	100	nA	
Transconductance	$g_{ m fs}$	$V_{\rm CE} = 20V, I_{\rm C} = 15A$	-	8.7	-	S	
Integrated gate resistor	R <sub>Gint</sub>			-		Ω	

### Dynamic Characteristic

Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	860	-	pF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	55	-	
Reverse transfer capacitance	Crss	f=1MHz	-	24	-	
Gate charge	Q <sub>Gate</sub>	$V_{\rm CC} = 480 \text{V}, I_{\rm C} = 15 \text{A}$	-	87	-	nC
		$V_{GE}=15V$				
Internal emitter inductance	L <sub>E</sub>		-	7	-	nH
measured 5mm (0.197 in.) from case						
Short circuit collector current <sup>1)</sup>	I <sub>C(SC)</sub>	$V_{GE} = 15V, t_{SC} \le 5\mu s$ $V_{CC} = 400V,$ $T_{j} = 150^{\circ}C$	-	137.5	-	A

<sup>1)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



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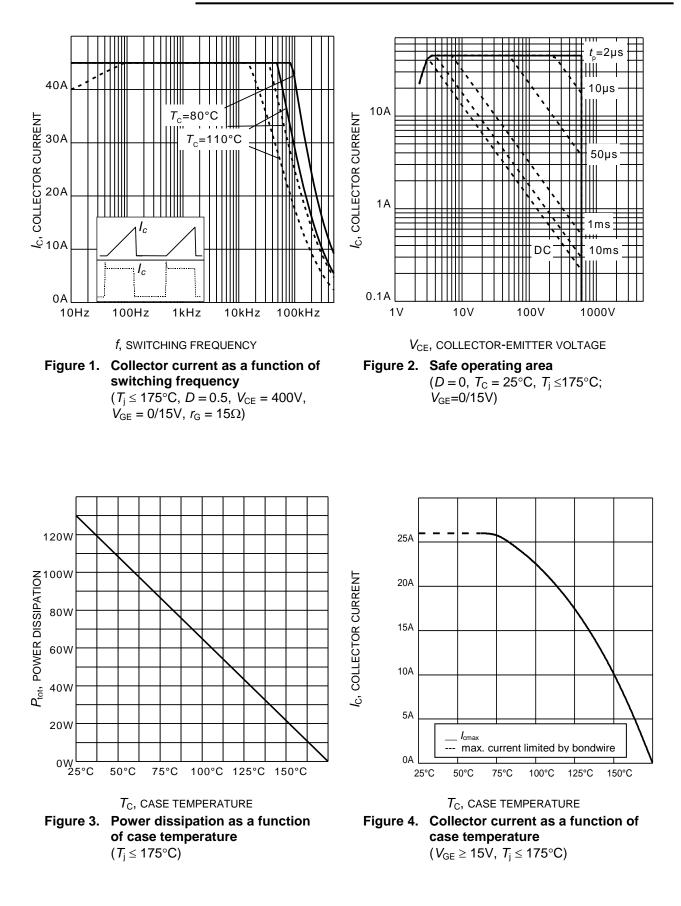
#### Switching Characteristic, Inductive Load, at $T_i=25$ °C

Deremeter	Symbol	Conditions	Value			11
Parameter	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic						
Turn-on delay time	t <sub>d(on)</sub>	$T_{j}=25^{\circ}C,$ $V_{CC}=400V, I_{C}=15A,$ $V_{GE}=0/15V, r_{G}=15\Omega,$ $L_{\sigma}=154nH, C_{\sigma}=39pF$	-	17	-	ns
Rise time	t <sub>r</sub>		-	11	-	
Turn-off delay time	$t_{d(off)}$		-	188	-	
Fall time	t <sub>f</sub>	]	-	50	-	
Turn-on energy	Eon	$L_{\sigma}$ , $C_{\sigma}$ from Fig. E Energy losses include "tail" and diode reverse	-	0.22	-	mJ
Turn-off energy	E <sub>off</sub>		-	0.35	-	
Total switching energy	E <sub>ts</sub>	Diode from IKW30N60T	-	0.57	-	

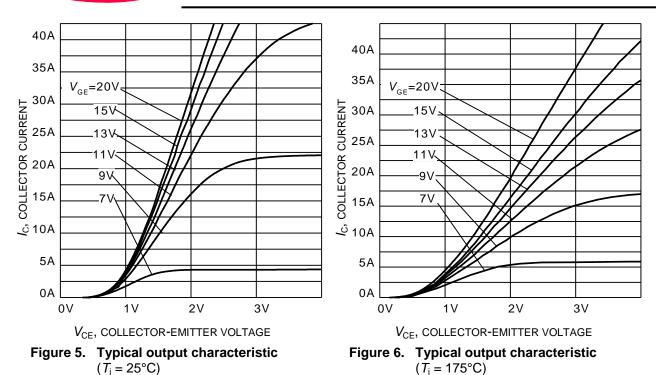
### Switching Characteristic, Inductive Load, at $T_j$ =175 °C

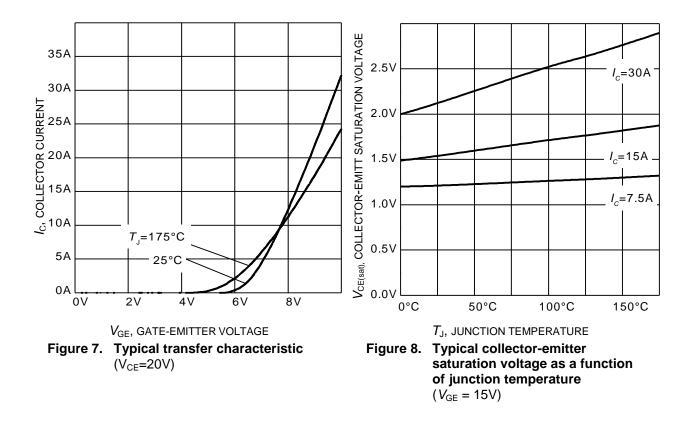
Parameter	Cumb of	Conditions	Value			11
Parameter	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic						
Turn-on delay time	t <sub>d(on)</sub>	$T_{j}=175^{\circ}C,$ $V_{CC}=400V, I_{C}=15A,$ $V_{GE}=0/15V, r_{G}=15\Omega,$ $L_{\sigma}=154nH, C_{\sigma}=39pF$	-	17	-	ns
Rise time	t <sub>r</sub>		-	15	-	
Turn-off delay time	$t_{d(off)}$		-	212	-	
Fall time	t <sub>f</sub>		-	79	-	
Turn-on energy	Eon	$L_{\sigma}$ , $C_{\sigma}$ from Fig. E Energy losses include "tail" and diode reverse	-	0.34	-	mJ
Turn-off energy	E <sub>off</sub>		-	0.47	-	
Total switching energy	E <sub>ts</sub>	Diode from IKW30N60T	-	0.81	-	





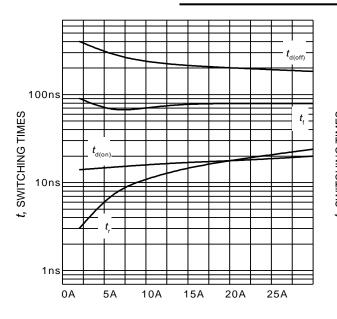






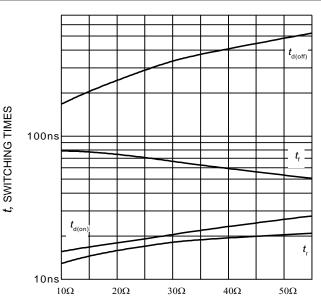


## TRENCHSTOP™ Series

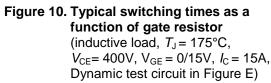


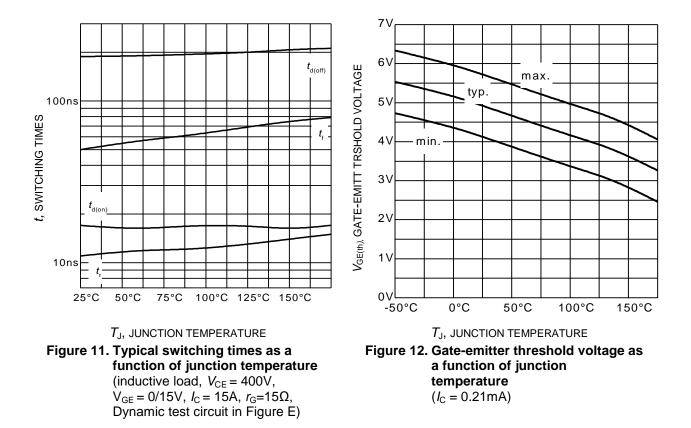
 $I_{\rm C}$ , COLLECTOR CURRENT

Figure 9. Typical switching times as a function of collector current (inductive load,  $T_J$ =175°C,  $V_{CE}$  = 400V,  $V_{GE}$  = 0/15V,  $r_G$  = 15 $\Omega$ , Dynamic test circuit in Figure E)



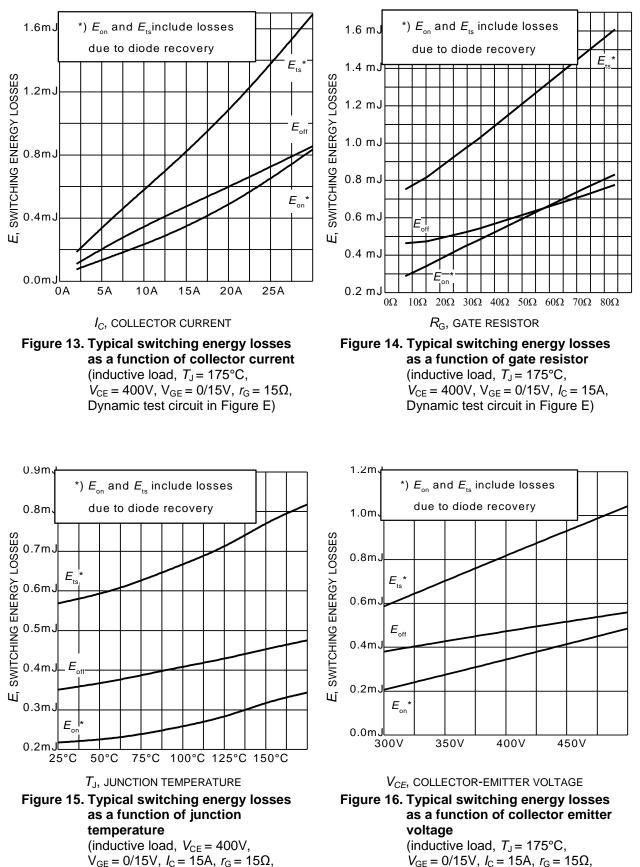








## **TRENCHSTOP™** Series

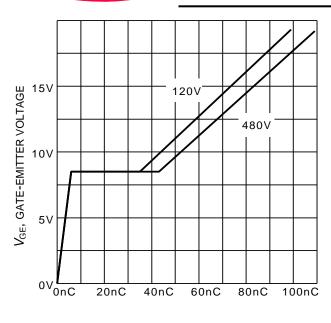


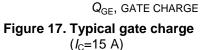
 $V_{\rm GE} = 0/15 \text{V}, I_{\rm C} = 15 \text{A}, r_{\rm G} = 15 \Omega,$ Dynamic test circuit in Figure E)

Dynamic test circuit in Figure E)









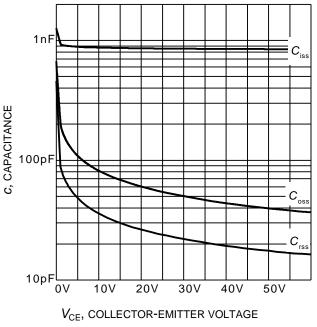
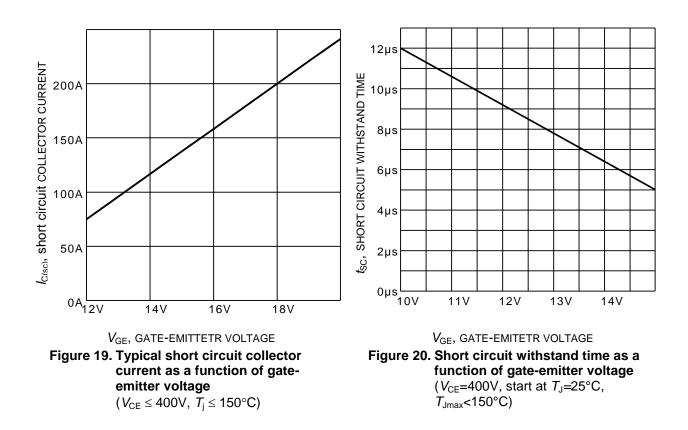
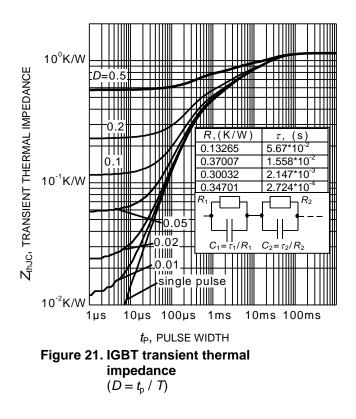


Figure 18. Typical capacitance as a function of collector-emitter voltage  $(V_{GE}=0V, f = 1 \text{ MHz})$ 



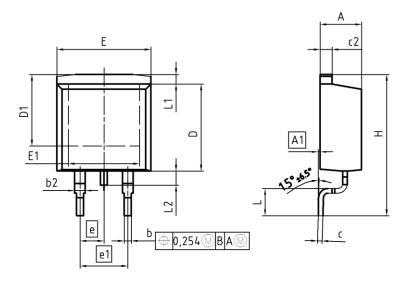


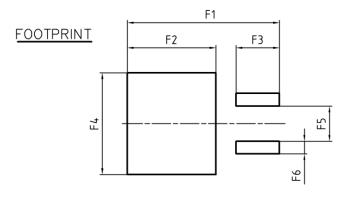




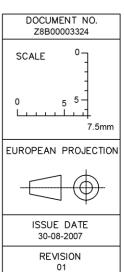
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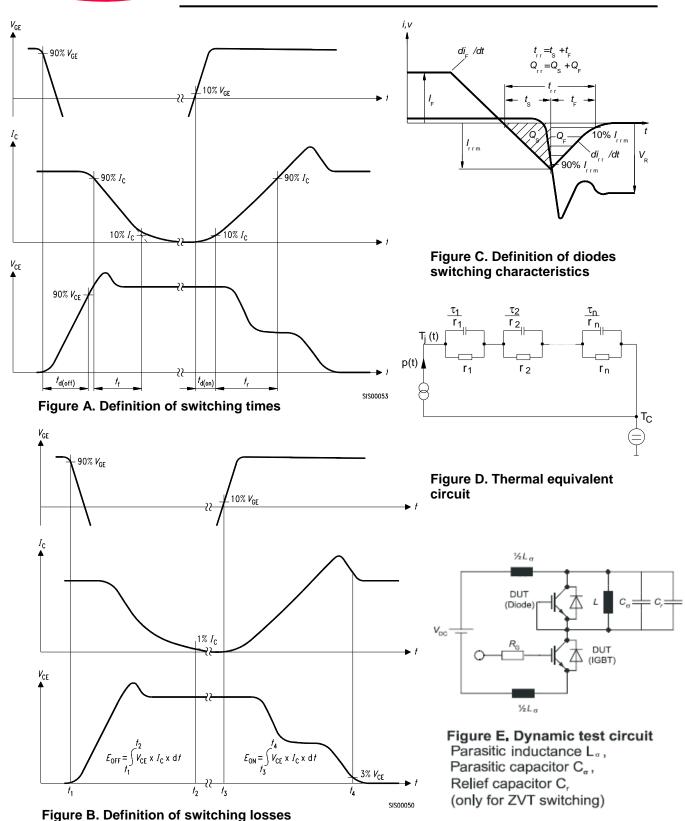




DIM	MILLIM	ETERS	INC	HES		
	MIN	MAX	MIN	MAX		
A	4.30	4.57	0.169	0.180		
A1	0.00	0.25	0.000	0.010	7	
b	0.65	0.85	0.026	0.033	7 Г	
b2	0.95	1.15	0.037	0.045	7	
с	0.33	0.65	0.013	0.026	7	
c2	1.17	1.40	0.046	0.055		
D	8.51	9.45	0.335	0.372		
D1	7.10	7.90	0.280	0.311	7	
E	9.80	10.31	0.386	0.406		
E1	6.50	8.60	0.256	0.339		
е	2.5	2.54		0.100		
e1	5.0	5.08		0.200		
N		2				
Н	14.61	15.88	0.575	0.625	ר ו'	
L	2.29	3.00	0.090	0.118		
L1	0.70	1.60	0.028	0.063		
L2	1.00	1.78	0.039	0.070		
F1	16.05	16.25	0.632	0.640		
F2	9.30	9.50	0.366	0.374	7	
F3	4.50	4.70	0.177	0.185	7	
F4	10.70	10.90	0.421	0.429	$\neg \vdash$	
F5	3.65	3.85	0.144	0.152	7	
F6	1.25	1.45	0.049	0.057		









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